

Features

- 1) Low on-resistance
- 2) Fast switching speed
- 3) Fast reverse recovery
- 4) Easy to parallel
- 5) Simple to drive
- 6) Pb-free lead plating ; RoHS compliant

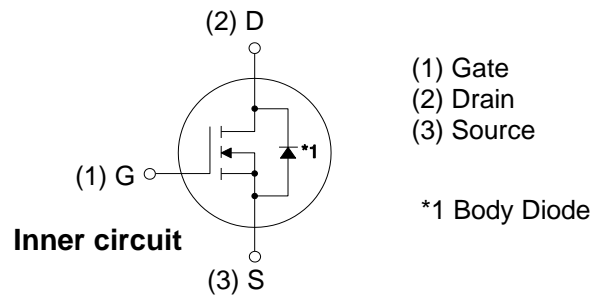
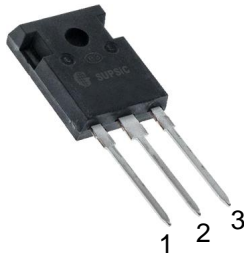
Parameter	Rating	Units
V_{DS}	1200	V
$I_D @ 25^\circ\text{C}$	82	A
$R_{DS(on)}$	21	m Ω



Applications

- Solar inverters
- DC/DC converters
- Switch mode power supplies
- Induction heating

TO-247-3
Package



Maximum Ratings ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain - Source Voltage	1200	V	$V_{GS} = 0\text{ V}, I_b = 100\ \mu\text{A}$	
V_{GSmax}	Gate - Source Voltage (dynamic)	-8/+19	V	AC ($f > 1\text{ Hz}$)	
V_{GSop}	Gate - Source Voltage (static)	-4/+15	V	Static	
I_D	Continuous Drain Current	82	A	$V_{GS} = 15\text{ V}, T_C = 25^\circ\text{C}$	
		58		$V_{GS} = 15\text{ V}, T_C = 100^\circ\text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	200	A	Pulse width t_p limited by T_{jmax}	
P_D	Power Dissipation	472	W	$T_C = 25^\circ\text{C}, T_J = 175^\circ\text{C}$	
T_J, T_{stg}	Operating Junction and Storage Temperature	-40 to +175	$^\circ\text{C}$		
T_L	Solder Temperature	260	$^\circ\text{C}$	1.6mm (0.063") from case for 10s	
M_d	Mounting Torque	1	Nm lbf-in	M3 or 6-32 screw	
		8.8			

Note (1): When using MOSFET Body Diode $V_{GSmax} = -4\text{V}/+19\text{V}$

Note (2): MOSFET can also safely operate at $0/+15\text{ V}$

Note (3): Die limits are 100A (25°C) and 74A (100°C)

Electrical Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1200			V	$V_{GS} = 0\text{ V}, I_D = 100\ \mu\text{A}$	
$V_{GS(th)}$	Gate Threshold Voltage	1.8	2.5	3.6	V	$V_{DS} = V_{GS}, I_D = 17.7\ \text{mA}$	
			2.0		V	$V_{DS} = V_{GS}, I_D = 17.7\ \text{mA}, T_J = 175^\circ\text{C}$	
I_{DSS}	Zero Gate Voltage Drain Current		1	50	μA	$V_{DS} = 1200\ \text{V}, V_{GS} = 0\ \text{V}$	
I_{GSS}	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15\ \text{V}, V_{DS} = 0\ \text{V}$	
$R_{DS(on)}$	Drain-Source On-State Resistance	14.7	21	28	m Ω	$V_{GS} = 15\ \text{V}, I_D = 50\ \text{A}$	
			38			$V_{GS} = 15\ \text{V}, I_D = 50\ \text{A}, T_J = 175^\circ\text{C}$	
g_{fs}	Transconductance		35		S	$V_{DS} = 20\ \text{V}, I_{DS} = 50\ \text{A}$	
			33			$V_{DS} = 20\ \text{V}, I_{DS} = 50\ \text{A}, T_J = 175^\circ\text{C}$	
C_{iss}	Input Capacitance		4620		pF	$V_{GS} = 0\ \text{V}, V_{DS} = 800\ \text{V}$ $f = 100\ \text{KHz}$ $V_{AC} = 25\ \text{mV}$	
C_{oss}	Output Capacitance		180				
C_{riss}	Reverse Transfer Capacitance		12				
E_{oss}	C_{oss} Stored Energy		99				μJ
E_{ON}	Turn-On Switching Energy (SiC Diode FWD)		3.05		mJ	$V_{DS} = 800\ \text{V}, V_{GS} = -4\ \text{V}/+15\ \text{V}, I_D = 50\ \text{A},$ $R_{G(ext)} = 5\ \Omega, L = 65.7\ \mu\text{H}, T_J = 175^\circ\text{C}$	
E_{OFF}	Turn Off Switching Energy (SiC Diode FWD)		1.67				
E_{ON}	Turn-On Switching Energy (Body Diode FWD)		4.65		mJ	$V_{DS} = 800\ \text{V}, V_{GS} = -4\ \text{V}/+15\ \text{V}, I_D = 50\ \text{A},$ $R_{G(ext)} = 5\ \Omega, L = 65.7\ \mu\text{H}, T_J = 175^\circ\text{C}$	
E_{OFF}	Turn Off Switching Energy (Body Diode FWD)		1.58				
$t_{d(on)}$	Turn-On Delay Time		148		ns	$V_{DD} = 800\ \text{V}, V_{GS} = -4\ \text{V}/15\ \text{V}$ $R_{G(ext)} = 2.5\ \Omega, L = 65.7\ \mu\text{H}$ Timing relative to VDS, Inductive load	
t_r	Rise Time		27				
$t_{d(off)}$	Turn-Off Delay Time		72				
t_f	Fall Time		25				
$R_{G(int)}$	Internal Gate Resistance		3.3		Ω	$f = 1\ \text{MHz}, V_{AC} = 25\ \text{mV}$	
Q_{gs}	Gate to Source Charge		51		nC	$V_{DS} = 800\ \text{V}, V_{GS} = -4\ \text{V}/15\ \text{V}$ $I_D = 50\ \text{A}$ Per IEC60747-8-4 pg 21	
Q_{gd}	Gate to Drain Charge		54				
Q_g	Total Gate Charge		158				

Reverse Diode Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise specified)

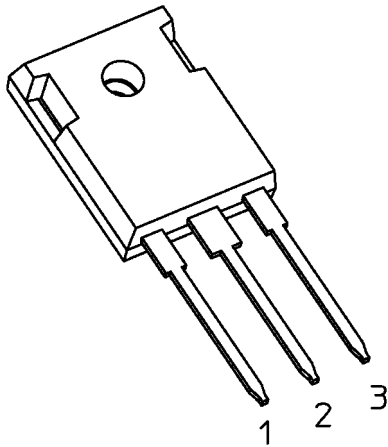
Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.6		V	$V_{GS} = -4\ \text{V}, I_{SD} = 25\ \text{A}, T_J = 25^\circ\text{C}$	
		4.2		V	$V_{GS} = -4\ \text{V}, I_{SD} = 25\ \text{A}, T_J = 175^\circ\text{C}$	
I_S	Continuous Diode Forward Current		90	A	$V_{GS} = -4\ \text{V}, T_C = 25^\circ\text{C}$	
$I_{S, pulse}$	Diode pulse Current		200	A	$V_{GS} = -4\ \text{V},$ pulse width t_p limited by T_{jmax}	
t_{rr}	Reverse Recover time	81		ns	$V_{GS} = -4\ \text{V}, I_{SD} = 50\ \text{A}, V_R = 800\ \text{V}$ $\text{dif}/\text{dt} = 1000\ \text{A}/\mu\text{s}, T_J = 175^\circ\text{C}$	
Q_{rr}	Reverse Recovery Charge	888		nC		
I_{rrm}	Peak Reverse Recovery Current	19		A		

Thermal Characteristics

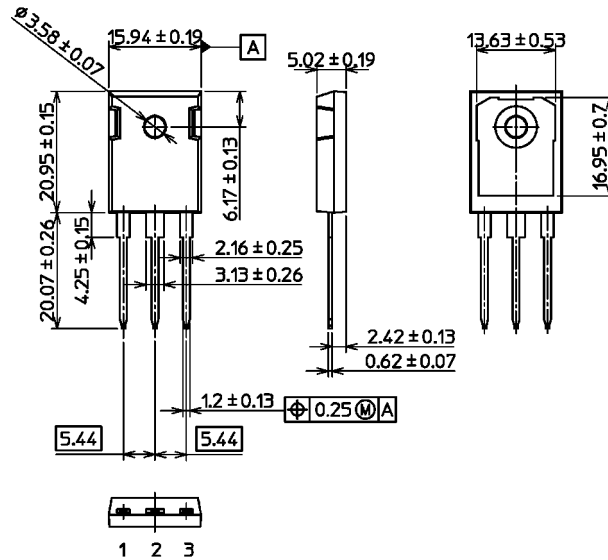
Symbol	Parameter	Typ.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.32	$^\circ\text{C}/\text{W}$		
$R_{\theta JA}$	Thermal Resistance From Junction to Ambient	40			

Package Dimensions

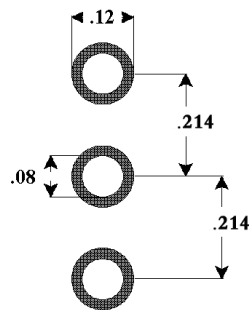
Unit: mm



TO-247-3



Recommended Solder Pad Layout



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